

Notice of References Cited	Application/Control No. 10/720,946		Applicant(s)/Patent Under Reexamination HODGES ET AL.	
	Examiner FREDA A. NELSON		Art Unit 3628	Page 1 of 1

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*	B	US-6,836,652	12-2004	Arima et al.	455/407
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.